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# Effect of Multiple Scattering on Radiation Transmission in Absorbing-Scattering Media

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A successive approximation procedure is developed to determine the scattering correction to the Beer-Lambert law in the evaluation of the geometric mean transmittance in a general multidimensional absorbing and scattering medium. At each step of the approximation, the evaluation of an upper and lower bound of the scattering correction requires only a single integral over the volume of the scattering medium. This represents a great reduction in mathematical complexity as compared to the direct numerical approach. Results for a two-dimensional rectangular absorbing and scattering medium are presented. The procedure is shown to converge rapidly in the optically thin limit. The lower-order results are useful for engineering application to media with arbitrary optical thickness. Some interesting conclusions concerning the qualitative physical behavior of the scattering correction are also generated.

#### Introduction

EASUREMENT of radiative transmission is a common Lexperimental technique for many engineering applications. In remote sensing, transmission measurements in different atmospheric absorption windows are used to determine surface temperatures, surface emissivity, and other important geographical data. In the study of thermal insulation, transmission measurements are used to determine effective radiative properties of many porous insulating materials.<sup>2</sup> In combustion, radiative transmission measurements are often used to determine flame properties. Most of the existing data reduction works assume that the transmissivity and the medium's optical thickness are related by the Beer-Lambert (B-L) law. The B-L law, however, fails for media that scatter as well as absorb radiation because the scattering process cannot be lumped together with the absorption process without a separate description. The accuracy of the conventional data reduction procedure for scattering media is thus uncertain.

In some recent works, 3,5 the deficiency of the B-L law assumption for scattering media is recognized. But almost without exception, all of the existing works consider only infinite or semi-infinite scattering media with a parallel slab geometry. For many practical situations, in which the scattering medium is finite, the applicability of the numerical results and the solution techniques developed in these works appears doubtful. The objective of this work is to present a successive approximation procedure, based on which the scattering correction to the B-L law for media with general geometry can be estimated to within an arbitrary degree of accuracy. Only isotropic scattering is considered. Generalization of the present work to media with anisotropic scattering is quite straightforward and will be presented in future works. Specifically, successively improved estimates of the upper and lower bound of the scattering correction can ge generated by the present technique with little mathematical complexity. Unlike a straightforward numerical computational approach involving multiple-variable integration, which are time con-

bound to the correction factor can be written as <sup>6</sup>  $\omega = (\vec{n} \cdot \vec{r_1})e^{-(L_1 + r_1)}$ 

suming even on large main frame computers, the present ap-

proach requires only a single integration over the scattering

volume for each successive approximation. For engineering

applications in which a high degree of accuracy is not required

for the geometric mean transmittance, the present approach is

particularly convenient because the lower order results, which

can be generated with little mathematical complexity, are suf-

ficient. Numerical results for a two-dimensional rectangular

scattering medium are presented to illustrate the effectiveness

of the present solution approach. Based on these results, some

general conclusions concerning the qualitative physical

Analysis

tervening absorbing-scattering medium, and the associated

coordinate system and geometry as shown in Fig. 1. To il-

lustrate the effect of scattering, the geometric-mean transmit-

 $dF_{d0-dA}\tau_{d0-dA} = dF_{d0-dA}(\tau_{d0-dA}^0 + \tau_{d0-dA}^S)$ 

where  $dF_{d0-dA}$  is the differential shape factor between  $dA_0$  and

dA,  $\tau_{d0-dA}^0$  is the transmissivity between  $dA_0$  and dA without

scattering, and  $\tau_{d0-dA}^s$  is the scattering correction. Both  $dA_0$ 

and dA are assumed to be diffusely emitting and absorbing

surfaces in the development of Eq. (1). The transmissivity

 $\tau_{\text{d0-d4}}^0 = e^{-L}$ 

with L being the optical thickness of a line of sight between the

two areas. Utilizing the same approach as developed in

without scattering, based on the B-L law, is given by

Consider the two differential areas  $dA_0$  and dA, with an in-

behavior of the scattering correction are generated.

tance between  $dA_0$  and dA can be written as

$$dF_{d0-dA}\tau_{d0-dA}^{s}]_{\ell}^{1} = \frac{\omega}{4\pi^{2}}dA\int_{V_{I}} \frac{z_{1}(\vec{n}\cdot\vec{r_{1}})e^{-(L_{1}+r_{1})}}{(L_{I}r_{I})^{3}}dV_{1}$$
 (2)

The geometry for this calculation is shown in Fig. 2 with  $\omega$  the scattering albedo, while

$$\vec{L}_1 = x_1 \hat{i} + y_1 \hat{j} + z_1 \hat{k}$$
 (2a)

previous works, 6,7 a series of successively improved estimates of the lower and upper bound of the scattering correction can be generated by some simple physical reasoning.

For example, if only the scattering correction due to single scattering is considered, a first-order estimate of the lower bound to the correction factor can be written as 6

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and

$$\vec{r}_1 = (x - x_1)\hat{i} + (y - y_1)\hat{j} + (z - z_1)\hat{k}$$
 (2b)

Physically Eq. (2) represents the fraction of energy that, after leaving  $dA_0$ , is scattered once into the line-of-sight direction from  $dV_1$  to dA. Similarly, the first-order approximation of the upper limit of the scattering correction,  $[\tau_{d1-d2}^d]_u^1$  can be written as

$$dF_{d0-dA}\tau_{d0-dA}^{s}]_{u}^{1} = \frac{\omega}{\pi} \int_{V_{I}} \frac{z_{I}e^{-L_{I}}}{L_{1}^{3}} dV_{1}$$

$$-\int_{A_{s}-dA} dF_{d0-dA} \tau_{d0-dA} \right]_{\ell}^{1}$$
 (3)

Physically, the first term in Eq. (3) represents the total amount of energy that has experienced a single scattering by the medium. The second term represents the minimum portion of that energy, which is intercepted by the boundary of the scattering volume, except dA. The difference between the two terms clearly represents an upper bound of the scattering correction to the B-L law.

The above development can be readily generalized to estimate higher-order results for the upper and lower limits of the scattering correction. In the nth order, the lower bound of  $\tau_{\text{d0-dA}}^s$  can be written recursively in terms of the (n-1)th order results as

$$dF_{d0-dA}\tau_{d0-dA}^{s}]_{\ell}^{n} = dF_{d0-dA}\tau_{d0-dA}^{s}]_{\ell}^{n-1} + \left(\frac{1}{\pi}\right)\left(\frac{\omega}{4\pi}\right)^{n}dAK_{n}$$
(4)

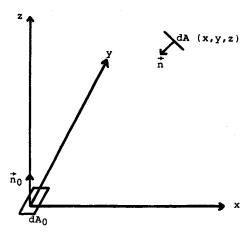


Fig. 1 Coordinate system and geometry.

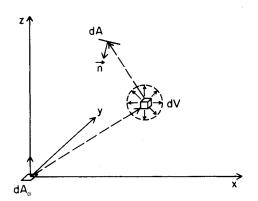


Fig. 2 Geometry for first-order calculation

where

$$K_n = \int_{V_s} \frac{(\vec{n} \cdot \vec{r}) e^{-r}}{r^3} J_{n-1}(V) dV$$
 (5)

with

$$J_0 = z_1 e^{-L_I} / L_1^3 \tag{6}$$

$$J_{n}(V) = \int J_{n-1}(V') \frac{e^{-r'}}{r'^{2}} dV'$$
 (6a)

and

$$\vec{r} = (x - x_a)\hat{i} + (y - y_A)\hat{j} + (z - z_A)\hat{k}$$
 (7a)

$$\vec{r}' = (x - x')\hat{i} + (y + y')\hat{j} + (z - z')\hat{\rho}$$
 (7b)

The subscript A denotes the coordinates of dA and the supercript prime denotes a variable of integration. The upper bound of the scattering correction is given by

$$dF_{d0-dA}\tau_{d0-dA}^{s}]_{u}^{n} = dF_{d0-dA}\tau_{d0-dA}^{s}]_{\ell}^{n-1}$$

$$+\left(\frac{\omega}{\pi}\right)\left(\frac{\omega}{4\pi}\right)^{n-1}\int J_{n-1}(V)dV$$
$$-\left(\frac{\omega}{\pi}\right)\left(\frac{\omega}{4\pi}\right)^{n}\int_{A_{s}-dA}K_{n}dA_{s} \tag{8}$$

The advantage of the present technique in contrast to a straightforward numerical computation approach is apparent. At each order of the approximation, evaluations of  $K_n$  and  $J_n$  involve only a single numerical integration over the scattering medium. The integrand requires the value of  $J_{n-1}$  which is tabulated in the (n-1)th approximation.

#### **Application**

As an illustration of the importance of the scattering effect and of the effectiveness of the present solution technique, the geometric-mean transmittance between an infinitesimal area  $\mathrm{d}A_0$  and a finite detecting area A will be calculated. In order to simplify the calculations, the medium and the detecting area will be assumed to be infinite in the y direction. The specific geometry is illustrated in Fig. 3. The geometric-mean transmittance  $F_{\mathrm{d0-A}}\tau_{\mathrm{d0-A}}$  with A being both the top and side surface, will be evaluated. It is important to note that because of symmetry, the present results can also be interpreted as the radiative transfer between a finite source area A and an infinitesimal detecting area  $\mathrm{d}A_0$ .

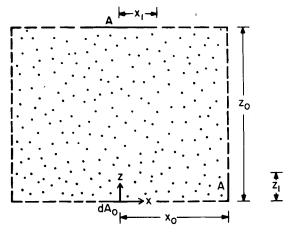


Fig. 3 Coordinate system and geometry for the two-dimensional application.

Since the medium is infinite in the y direction, Eqs. (5) and (6) may be simplified to yield

$$K_n = \pi \int \frac{(\vec{n} \cdot \vec{r}) S_n(r)}{r^2} J_{n-1}(x, z) dx dz$$
 (9)

$$J_n(x,z) = \pi^n \int J_{n-1}(x',z') \frac{S_1(r')}{r'} dx' dz'$$
 (10)

where

$$r = [(x_A - x)^2 + (z_A - z)^2]^{\frac{1}{2}}$$
 (10a)

and

$$r' = [(x-x')^2 + (z-z')^2]^{\frac{1}{2}}$$
 (10b)

Note from Fig. 3 that  $z_A = z_0$  when the detecting area is at the upper surface and  $x_A = x_0$  when the detecting area is at the side surface. In addition  $J_0$  can be simplified as

$$J_0 = zS_2(L)/L^2 (11a)$$

where

$$L = (x^2 + z^2)^{1/2} \tag{11b}$$

 $S_1(x)$  and  $S_2(x)$  are generalized exponential functions, which have been studied extensively, and their numerical values and analytical properties are presented in Ref. 8. In general,  $S_n(x)$  is defined by

$$S_n(x) = \frac{1}{\pi} \int_{-\infty}^{\infty} \frac{e^{-(x^2 + y^2)^{1/2}}}{(x^2 + y^2)^{(n+1)/2}} dy$$
 (12)

Equations (2-4) and (8), together with Eqs. (9-11), provide all of the information necessary to evaluate the scattering correction for the geometry shown in Fig. 3.

#### Results and Discussion

#### **Top Surface**

In analyzing the radiation transfer to the top surface, there are three interesting parameters to vary: the optical thickness of the medium  $(z_0)$ , the optical width of the medium  $(x_0)$ , and the optical size of the detector  $(x_1)$ . These parameters are labeled in Fig. 3. To demonstrate the maximum effect of scattering of the scattering albedo,  $\omega$  is taken to be 1.0 in all of the calculations.

Since the scattering contribution to the geometric-mean transmittance is being calculated, it will be useful to have available the geometric-mean transmittance without the scattering contribution, (see Eq. 1). This is given in the present example as

$$F_{\text{d0-dA}} \tau_{\text{d0-dA}}^0 = \int_0^{x_1} z_0^2 \frac{S_3 \left[ (x^2 + z_0^2)^{x_1} \right]}{(x^2 + z_0^2)^{3/2}} dx$$
 (13)

Numerical values of this expression are plotted for various values of the detector in size  $x_1$  in Fig. 4 for comparison with the scattering contribution, which will follow.

Since the present solution technique is an iterative process, the rate of convergence is an important consideration. This rate is shown in Fig. 5. It is immediately obvious from the figure that increasing optical thickness decreases the rate of convergence. For optically thin media, the convergence is quite rapid. For media with larger optical thickness, convergence is not achieved until higher orders are calculated.

The numerical evaluation of the upper and lower limits of the scattering correction factor was carried out to sufficiently large n to insure that the relative difference between two successive approximations was less than 0.01, except in the cases

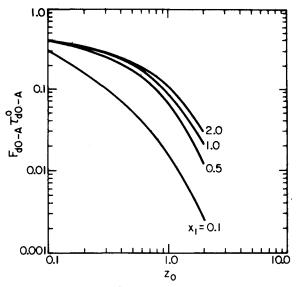


Fig. 4 Geometric-mean transmittance without the scattering contribution (top surface).

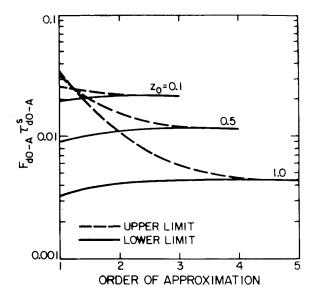


Fig. 5 Rate of convergence of the solution technique with  $x_1 = x_0 = 0.1$  (top surface).

with large optical thickness  $(z_0 > 1.0)$ , which converged slowly. In these cases, the numerical evaluation was carried out until n was approximately 9 or 10, and then a 'best estimate' of the converged value was made by considering the values of the upper and lower limits at the largest n,  $n_{\rm max}$ , and by calculating an average weighted by the relative changes of the two limits between  $n_{\rm max}$  and  $n_{\rm max} - 1$ .

The converged values can be used to illustrate quantitatively some general conclusions about scattering media. Figure 6 shows the variation of the scattering correction factor with optical thickness for various medium widths and for a fixed detector optical size  $x_1 = 0.1$ . The scattering correction factor reaches a maximum value at small optical thicknesses, if the medium width is equal to the detector size, and reaches a maximum value at increasing optical thicknesses as the medium width is increased above the detector size. The magnitude of the scattering correction factor appears to become quite insensitive to medium width when the medium width is greater than the detector size, especially for small vertical optical thickness  $z_0$ . This indicates that for an isotropically scattering medium, the contribution of the medium away from the line of sight to the scattering correction could be neglected. This conclusion

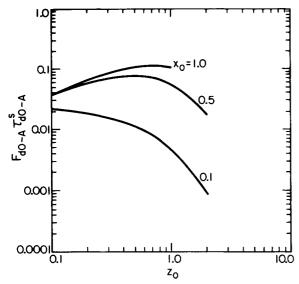


Fig. 6 Effect of the size of the scattering medium  $[x_0]$  on the scattering correction factor with  $x_1 = 0.1$  (top surface)].

can lead to considerable simplification of the mathematics involved in evaluating the scattering correction.

Values of the scattering correction factor are presented in Fig. 7 for different optical thicknesses and medium widths with the detector size equal to the medium width. It is interesting to compare these curves with the same information presented as a ratio of the scattering correction factor to the geometric-mean transmittance calculated without scattering, i.e.,

$$M = \frac{\tau_{\text{d0-}A}^{\varsigma}}{\tau_{\text{d0-}A}^{0}} \tag{14}$$

This ratio is plotted in Fig. 8. Figures 7 and 8 illustrate two possible interpretations of the relative importance of the scattering effect. For applications in which the magnitude of the scattering contribution is important, Fig. 7 indicates that scattering is important for systems with intermediate optical thickness, around  $z_0 = 0.5$  in the present case. For systems in which the relative magnitude of the scattering contribution is important, Fig. 8 indicates that scattering increases in importance with increasing optical thickness.

#### Side Surface

In the analysis of radiation transfer to the side surface, there are again three parameters to vary: the optical thickness of the medium  $(z_0)$ , the optical width of the medium  $(x_0)$ , and the optical size of the detector  $(z_1)$ . Note from Fig. 3 that  $z_1$  is measured from the lower corner.

The geometric-mean transmittance without the scattering contribution for this case is given by

$$F_{\text{d0-dA}} \tau_{\text{d0-dA}}^0 = \int_0^{z_1} \frac{z_1 x_0 S_3 \left[ (x_0^2 + z^2) \right]^{1/2}}{(x_0^2 + z^2)^{3/2}} dz$$
 (15)

This expression is plotted in Fig. 9 for comparison with the scattering contribution.

The rate of convergence of the process for the side surface is plotted in Fig. 10 with  $z_1 = z_0 = 0.1$ . It is apparent that the width of the scattering medium in this optically thin case has little effect on the rate of convergence. Figure 11 illustrates the rate of convergence for a case of larger optical thickness  $z_0 = 1$ . In this case, the dependence of rate of convergence on the width of the medium appears to be stronger. However, comparison of Fig. 11 with Fig. 10 shows that, as in the case of the top surface, rate of convergence depends fairly strongly on the optical thickness  $z_0$ .

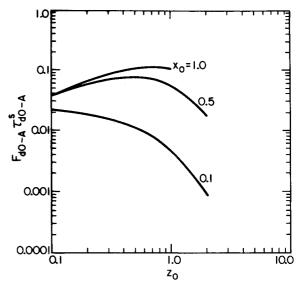


Fig. 7 The effect of optical thickness  $(z_0)$  for different  $x_0$  with  $x_1 = x_1x_0$  (top surface).

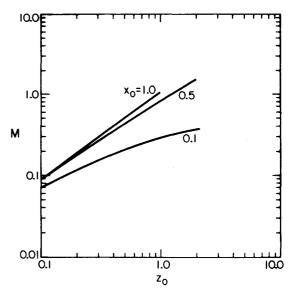


Fig. 8 Scattering factor M with  $M_1 = x_0$  (top surface).

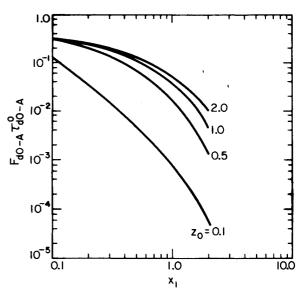


Fig. 9 Geometric-mean transmittance without the scattering contribution (side surface).

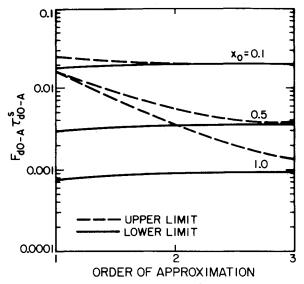


Fig. 10 Rate of convergence of the solution technique with  $z_1=z_0=0.1$  (side surface).

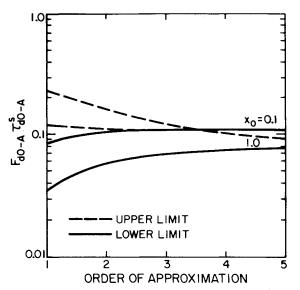


Fig. 11 Rate of convergence of the solution technique with  $z_1=z_0=1$  (side surface).

The magnitudes of the converged values of the scattering correction factor are plotted as a function of medium width in Fig. 12 for several values of  $z_0$  and  $x_0$ , with  $z_1 = 0.1$ . The scattering correction factor has its maximum values at small medium widths, as would be expected from physical considerations, since for large medium widths the detector is far away. The effect of  $z_0$  decreases rapidly as  $z_0$  becomes larger than the detector size  $z_1$ . This suggests that, as in the top surface case, the contribution of the medium away from the line of sight could be neglected, again suggesting a possible way to reduce the mathematical complexity of the calculation.

Figure 13 shows the scattering correction factor as a function of medium width for different  $x_0$ , with  $z_1 = z_0$ . As in the case of the top surface, this will be compared with the ratio of the scattering correction factor to the geometric-mean transmittance without scattering, as given by Eq. (14). This factor is plotted in Fig. 14. Figure 13 shows that the magnitude of the scattering correction factor for small  $z_0$  decreases as the horizontal optical thickness of the scattering medium  $x_0$  increases. For media with larger  $z_0$ , the magnitude reaches a maximum at intermediate  $x_0$ . This result also illustrates that for applications in which the magnitude of the scattering cor-

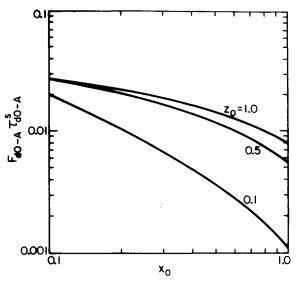


Fig. 12 Effect of optical thickness  $(z_0)$  with  $z_1 = 0.1$  (side surface).

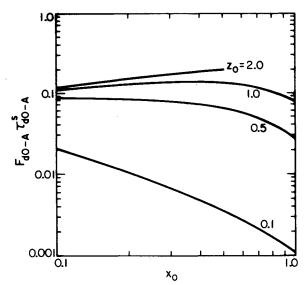


Fig. 13 The effect of  $z_0$  and  $x_0$  with  $z_1 = z_0$  (side surface).

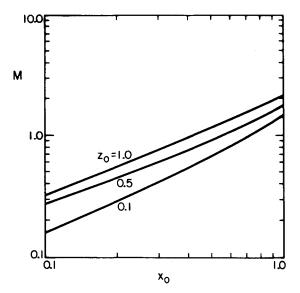


Fig. 14 Scattering factor M with  $z_1 = z_0$  (side surface).

rection factor is important, the effect of scattering increases with increasing  $Z_0$ . Figure 14 shows that for applications in which the relative value of the scattering correction factor is important, the role of scattering increases with both optical thickness  $z_0$  and medium width  $x_0$ .

#### **Conclusions**

A successive approximation procedure has been developed to determine the scattering correction to the geometric-mean transmittance in general multidimensional systems. At each step of the approximation, the upper and lower limits of the scattering correction can be calculated by a single integration over the volume of the scattering medium.

The application of this solution procedure to a twodimensional rectangular scattering medium allows some interesting conclusions to be drawn concerning the physics of scattering. They are

- 1) For an isotropically scattering medium, the most significant contribution to the scattering correction factor comes from the medium which lies along the line of sight between the source and the detecting area.
- 2) In terms of the absolute magnitude of the scattering correction factor, the scattering to the top surface reaches a maximum at intermediate optical depth, while the scattering to the side surface increases with increasing optical depth. The scattering to the top surface increases as the optical width of the medium (and the size of the detector) increases. As the optical width of the scattering medium increases, the scattering to the side surface decreases if the medium is optically thin, and increases to a maximum before decreasing if the medium is optically thick.

3) In terms of the relative magnitude of the scattering correction factor (related to the geometric-mean transmittance calculated without scattering) the importance of scattering increases with optical depth and width for both the top and side surfaces.

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